

## **FDS4470**

# 40V N-Channel PowerTrench® MOSFET

## **General Description**

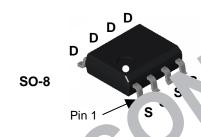
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{\text{DS(ON)}}$  and fast switching speed.

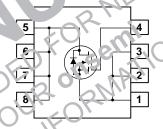
## **Applications**

DC/DC converter

### **Features**

- 12.5 A, 40 V.  $R_{DS(ON)} = 9 \text{ m}\Omega$  @  $V_{GS} = 10 \text{ V}$
- Low gate charge (45 nC)
- High performance trench t inolog for extremely low R<sub>DS(ON)</sub>
- High power a 1 cu. . nandling capability





Absolute Maxir. um Fatings 1,4=25°C un'ess runarwise noted

Symbol	Parameter	11.24	Ratings	Units
V <sub>DSS</sub>	Drain-Soi :e Voltage	17/2	40	V
V	ate-cource Voltage		+30/–20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	12.5	А
	- Pulsed		50	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
OE.	1 DEF	(Note 1b)	1.4	
CV		(Note 1c)	1.2	
TJ, T <sub>STG</sub>	Operating and Storage Junction Temperat	ure Range	-55 to +175	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	125	°C/W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
FDS4470	FDS4470	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	ource Avalanche Ratings (Note 2	2)			I	
E <sub>AS</sub>	Drain-Source Avalanche Energy	Single Pulse, V <sub>DD</sub> =40V, I <sub>D</sub> =12.5A			370	mJ
I <sub>AS</sub>	Drain-Source Avalanche Current				12.5	Α
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	40			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to 25°C		42		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 32 \text{ V},  V_{GS} = 0 \text{ V}$			1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 30 \text{ V},  V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V},  V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)					1,5
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$		 3.ა	5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referencer' to 25		-8	U,	mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V},  I_D = 12 \text{ A}$ $V_{GS} = 10 \text{ V},  I_D = 5 \text{ A}$	2	9	9 14	mΩ
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = V <sub>1</sub> V <sub>L</sub> = 5 v	25	·W	7	A
g <sub>FS</sub>	Forward Transconductance	V 3 ⋅ 10 V, = 2.5 A	G	45		S
Dynamic	Characteristics	OF	0/1/2	n D	, ,	
C <sub>iss</sub>	Input Capacitance	$= 20 \text{ V},  \text{V}_{GS} = 0 \text{ V},$	0	2659		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz	$\bigcirc$	605		pF
C <sub>rss</sub>	Reverse Transfer Ca citance	William A O Will		298		pF
Switchin	g Charact ristics	-0'C1 2 11				
t <sub>d(on)</sub>	Turn- ↑ D€ v Time	$V_{DD} = 20$ v, $I_D = (A)$		14	25	ns
t <sub>r</sub>	T( 1-On Dise	$V_{CG} = 10 \text{ V},  R_{CEN} = 6 \Omega$		12	22	ns
t <sub>d(off)</sub>	Turn-Off D ay Time	D. WE		37	59	ns
t <sub>f</sub>	n- all Time			29	46	ns
¢'	Total Gate Charge	$V_{DS} = 20 \text{ V},  I_D = 12.5 \text{ A},$		45	63	nC
Q <sub>gs</sub>	Gate -Scurce Cha oc	V <sub>GS</sub> = 10 V		11.2		nC
Q <sub>gd</sub>	Gata- Brain Cr a.roc			11		nC

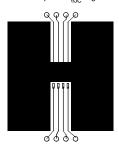
## **Electrical Characteristics**

 $T_{A} = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	Drain-Source Diode Characteristics and Maximum Ratings					
Is	Maximum Continuous Drain-Source Diode Forward Current				2.1	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = 2.1 \text{ A}$ (Note 2)		0.7	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 12.5 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$		33		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge			39		nC

#### Notes

1.  $R_{\text{BJA}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\text{BJC}}$  is guaranteed by design while  $R_{\text{BCA}}$  is determined by the user's board design.



a) 50°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper



b) 105°C/W when mounted on a .04 in pad of 2 oz copper



on a minin um pad.

7

Scale 1: 1 on letter size paper

2. Pulse Test: Pulse Width < 300us. Duty Cycle < 2.09

## **Typical Characteristics**

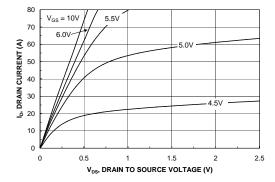


Figure 1. On-Region Characteristics.

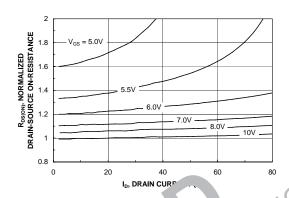


Figure 2. On-Restance 'aris on with Drain Curre '2' A Gat Soltage.

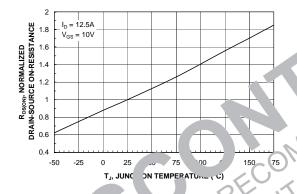


Figure ... esistance Variation with mperature.

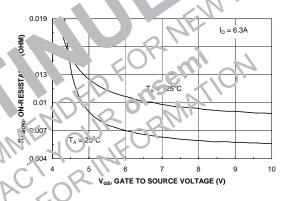


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

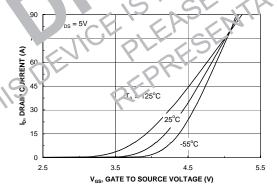


Figure 5. Transfer Characteristics.

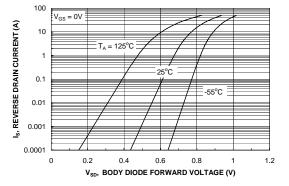
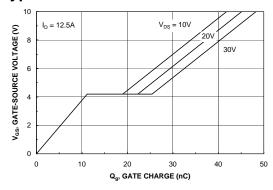


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



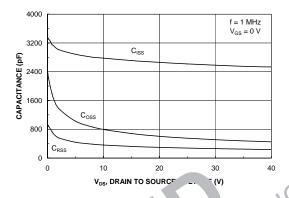
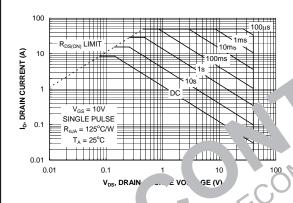


Figure 7. Gate Charge Characteristics.





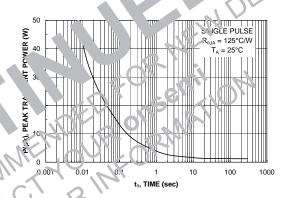


Figure 9. / aximun Pafe Operating Area



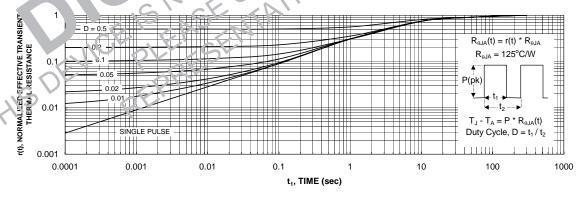


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.



### FAIRCHILD SEMICONDUCTOR TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACFx™ FACT Quiet Series™ SILENT SWITCHER® ActiveArray<sup>™</sup> GlobalOptoisolator™  $OCXPro^{TM}$ SMART START™ OPTOLOGIC® Bottomless™ GTO™ SPM™ Build it Now™ HiSeC™ OPTOPLANAR™ Stealth™ CoolFET™ I<sup>2</sup>C™ PACMAN™ SuperFET™ CROSSVOLT™ i-Lo™ POP™ SuperSOT™-3 DOME™ ImpliedDisconnect™ Power247™ SuperSOT™-6 PowerEdge™ SuperSOT™-8 EcoSPARK™ IntelliMAX™  $E^2CMOS^\intercal$ ISOPLANAR™ PowerSaver™ SyncFET™ RNEWDESIGN PowerTrench® TCM™ EnSigna™ LittleFET™ FACT<sup>®</sup> MICROCOUPLER™ QFET<sup>®</sup> TinyBoost™  $\mathsf{FAST}^{\circledR}$ QS™ MicroFET™ TinyBuck™ TinyPWM™ FASTr™ MicroPak™ QT Optoelectronics™ TinyPower™ FPS™ MICROWIRE™ Quiet Series™ RapidConfigure™ FRFET™ MSX™ TinyLogic MSXPro™ RapidConnect™ TIN OPTO µSerDes™ ru1. rslatio ™ Across the board. Around the world.™ The Power Franchise® ScalarPump™ Programmable Active Droop™

### **DISCLAIMER**

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHTO MATCHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN, FAIR THE DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR COUNTY OF THE SCRIBED HEREIN WEITHER FORS IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHER SEMENTALITY. SEE SPECIFICATIONS DO NOT EXPANDITURE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITION OF THE TICLUTE WAPRANTY. THEREIN, WHICH COVERS THESE PRODUCTS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS RE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT FE. RESS. RITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein

1. Life suppor 'evices or sy ems are devices or systems which, inplant into the body or (b) support or ndec r su in sur in life, (c, hose railure to perform when properly used in accordance volume in actions for use provided in the labeling, can be reas ably exected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

UniFET™

VCX™

Wire™

### PRODUCT STATUS DEFINITIONS

#### Definition of Terms

Davasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.



ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and h

### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlitt@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative